

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,853	CHANG ET AL.	L.
Examiner	Art Unit	
Scott Sun	2182	

	SEAR	CHED	
Class	Subclass	Date	Examiner
710	8, 62	8/16/2005	55
711	105, 115	8/16/2005	55
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEAR	NOTES CH STRATEGY	()
	DATE	EXMR
See attached (1 page)	8/16/2005	55
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